

<b>Notice of References Cited</b>	Application/Control No. 09/574,453	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Thierry L. Pham	Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,573,927	06-2003	Parulski et al.	348/32
	B	US-6,453,071	09-2002	Ito et al.	382/232
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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